

TOSHIBA Transistor Silicon NPN Epitaxial Type

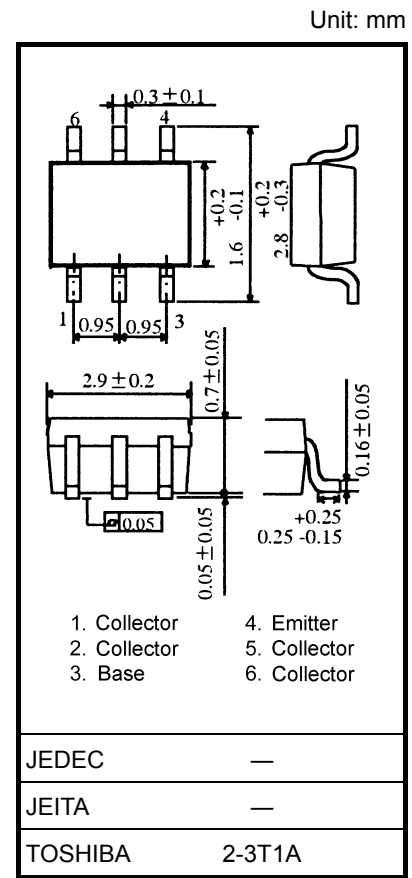
TPC6502

High-Speed Switching Applications
 DC/DC Converter Applications
 Strobe Applications

- High DC current gain: $h_{FE} = 400$ to 1000 ($I_C = 0.3$ A)
- Low collector-emitter saturation voltage: $V_{CE(sat)} = 0.14$ V (max)
- High-speed switching: $t_f = 120$ ns (typ.)

Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Collector-base voltage	V_{CBO}	100	V	
Collector-emitter voltage	V_{CEX}	80	V	
Collector-emitter voltage	V_{CEO}	50	V	
Emitter-base voltage	V_{EBO}	7	V	
Collector current	DC	I_C	3.0	A
	Pulse	I_{CP}	5.0	
Base current	I_B	300	mA	
Collector power dissipation	DC	P_C (Note 1)	0.8	W
	$t = 10$ s		1.6	
Junction temperature	T_j	150	°C	
Storage temperature range	T_{stg}	-55 to 150	°C	



Weight: 0.01 g (typ.)

Note 1: Mounted on an FR4 board (glass-epoxy; 1.6 mm thick; Cu area, 645 mm²)

Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit	
Collector cutoff current	I_{CBO}	$V_{CB} = 100\text{ V}, I_E = 0$	—	—	100	nA	
Emitter cutoff current	I_{EBO}	$V_{EB} = 7\text{ V}, I_C = 0$	—	—	100	nA	
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C = 10\text{ mA}, I_B = 0$	50	—	—	V	
DC current gain	$h_{FE(1)}$	$V_{CE} = 2\text{ V}, I_C = 0.3\text{ A}$	400	—	1000		
	$h_{FE(2)}$	$V_{CE} = 2\text{ V}, I_C = 1\text{ A}$	200	—	—		
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 1\text{ A}, I_B = 20\text{ mA}$	—	—	0.14	V	
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C = 1\text{ A}, I_B = 20\text{ mA}$	—	—	1.10	V	
Collector output capacitance	C_{ob}	$V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	13	—	pF	
Switching time	Rise time	t_r	See Figure 1 circuit diagram.		—	40	ns
	Storage time	t_{stg}	$V_{CC} \approx 30\text{ V}, R_L = 30\ \Omega$		—	500	
	Fall time	t_f	$I_{B1} = -I_{B2} = 33.3\text{ mA}$		—	120	

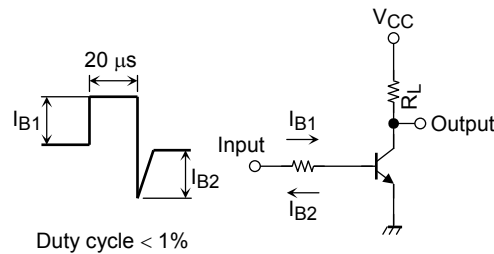
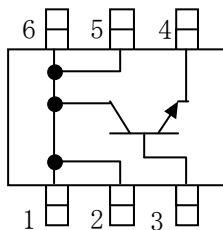
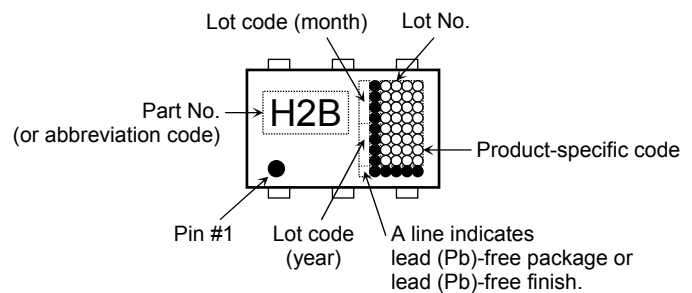


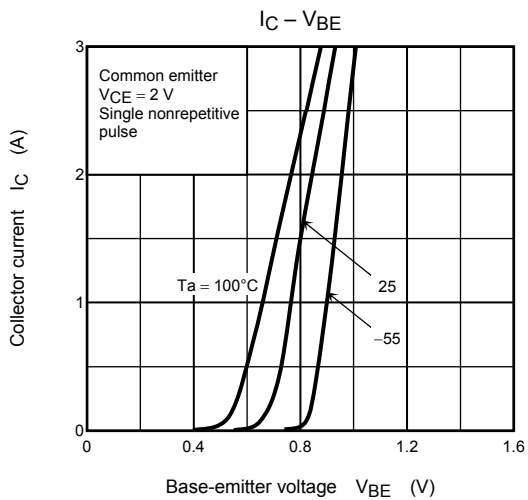
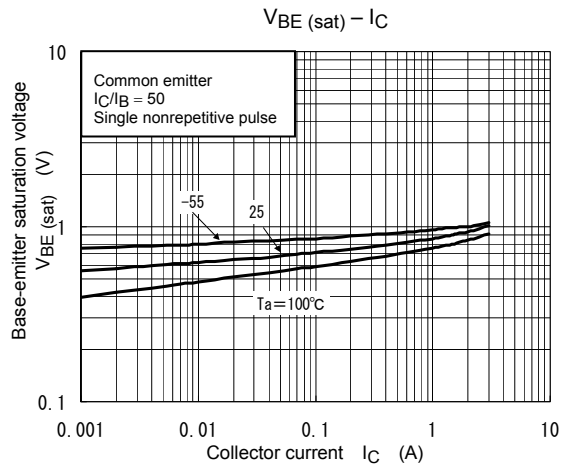
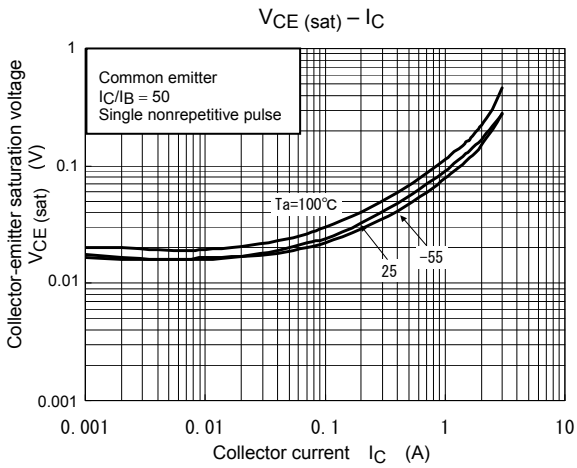
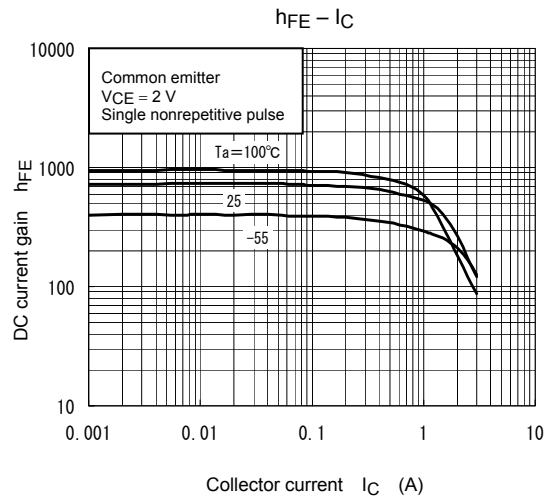
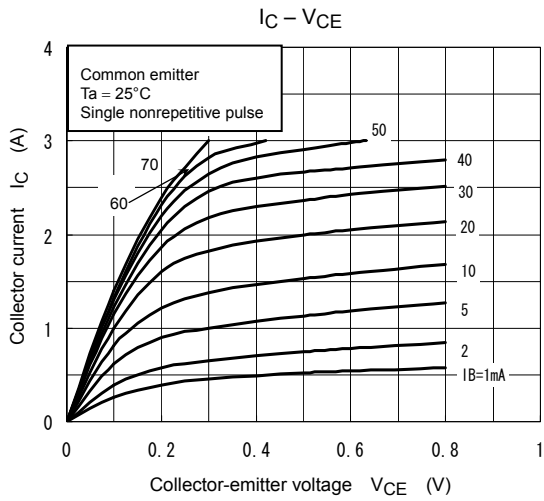
Figure 1. Switching Time Test Circuit & Timing Chart

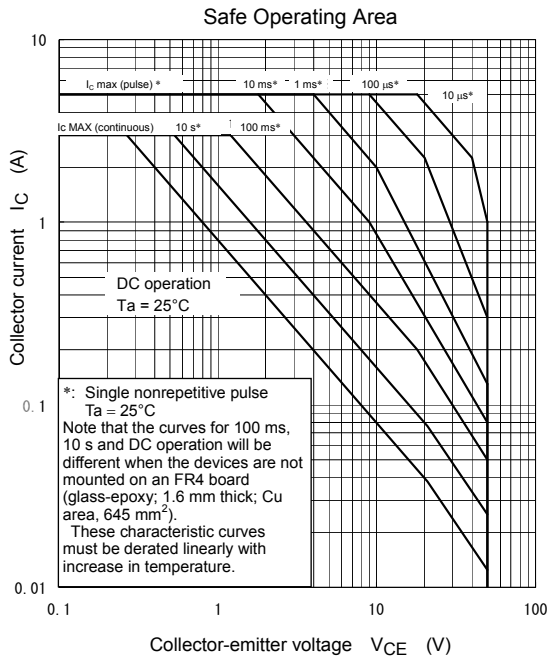
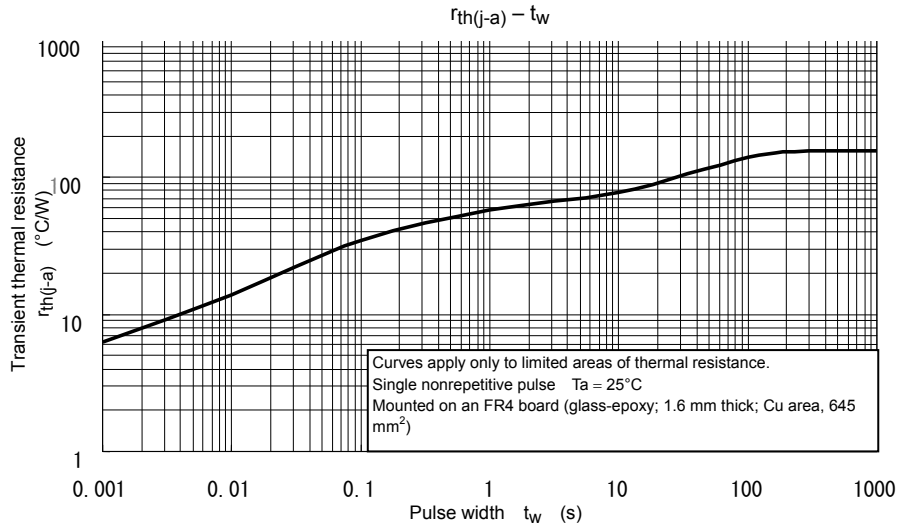
Circuit Configuration



Marking







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